

FORM PTO-1449

LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION DISCLOSURE
STATEMENT

(Use several sheets if necessary)

ATTY. DOCKET NO.

10004333-1

SERIAL NO.

APPLICANT

Kent W. Carey

FILING DATE

GROUP

10621 U.S. PRO
09/961119

09/20/01

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
	1A					
	1B					
	1C					
	1D					
	1E					
	1F					
	1G					
	1H					
	1I					
	1J					
	1K					

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	TRANSLATION	
							YES	NO
	1L							
	1M							
	1N							
	1O							
	1P							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

<i>Can</i>	1Q	"Optically Coherent Direct Modulated FM Analog Link with Phase Noise Canceling Circuit"; Robert Taylor et al.; Journal of Lightwave Technology, Vol. 17, No. 4; April 1999; pps. 556-563.
<i>Can</i>	1R	"Influence of Adjacent Channel Interference on the Frequency-Modulated WDM Optical Communication System"; Madhumita Bhattacharya et al.; Vol. 17, No. 12; December 1999; pps. 2516-2519.
<i>Can</i>	1S	"Amplitude-modulation-free Optoelectronic Frequency Control of Laser Diodes" B. Bodermann et al.; Optical Letters, Vol. 25, No. 12; June 15, 2000; pps. 899-901.

EXAMINER

Can

DATE CONSIDERED

09/07/04

FORM PTO-1449

LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION DISCLOSURE
STATEMENT

(Use several sheets if necessary)

ATTY. DOCKET NO.

10004333-1

SERIAL NO.

APPLICANT

Kent W. Carey

FILING DATE

GROUP

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
	2A					
	2B					
	2C					
	2D					
	2E					
	2F					
	2G					
	2H					
	2I					
	2J					
	2K					

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	TRANSLATION	
							YES	NO
	2L							
	2M							
	2N							
	2O							
	2P							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

CMM	2Q	"Design and Performance of a Narrowband VCO at 282 THz"; Peter R. Robrish et al.; Hewlett-Packard Journal; February 1995; pps. 63-66.
	2R	
	2S	

EXAMINER

DATE CONSIDERED

CMM

09/07/04